

Eudyna GaN-HEMT 180W

EGN21A180IV

Preliminary

High Voltage - High Power GaN-HEMT

FEATURES

- High Voltage Operation : $V_{DS}=50V$
- High Gain: 15dB(typ.) at $P_{out}=45dBm(Avg.)$
- High Efficiency: 32%(typ.) at $P_{out}=45dBm(Avg.)$
- Broad Frequency Range : 2100 to 2200MHz
- Proven Reliability

DESCRIPTION

The EGN21A180IV is a 180 Watt GaN-HEMT that offers high efficiency, high gain, ease of matching, greater consistency and broad bandwidth for high power L-band amplifiers with 50V operation. This device is targeted for high voltage, low current operation in digitally modulated base station applications - ideally suited for W-CDMA base station amplifiers and other HPA designs while offering ease of use.



ABSOLUTE MAXIMUM RATINGS

Item	Symbol	Condition	Rating	Unit
Drain-Source Voltage	V_{DS}		120	V
Gate-Source Voltage	V_{GS}	$T_c=25^\circ C$	-5	V
Total Power Dissipation	P_t		321	W
Storage Temperature	T_{stg}		-65 to +175	$^\circ C$
Channel Temperature	T_{ch}		250	$^\circ C$

RECOMMENDED OPERATING CONDITION(Case Temperature $T_c= 25^\circ C$)

Item	Symbol	Condition	Limit	Unit
DC Input Voltage	V_{DS}		50	V
Forward Gate Current	I_{GF}	$R_G=2 \Omega$	<38.8	mA
Reverse Gate Current	I_{GR}	$R_G=2 \Omega$	>-14.4	mA
Channel Temperature	T_{ch}		200	$^\circ C$

ELECTRICAL CHARACTERISTICS (Case Temperature $T_c=25^\circ C$)

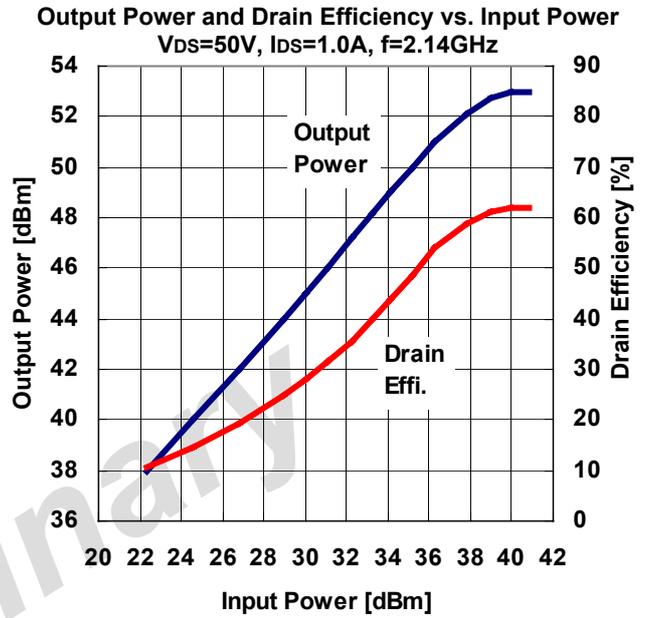
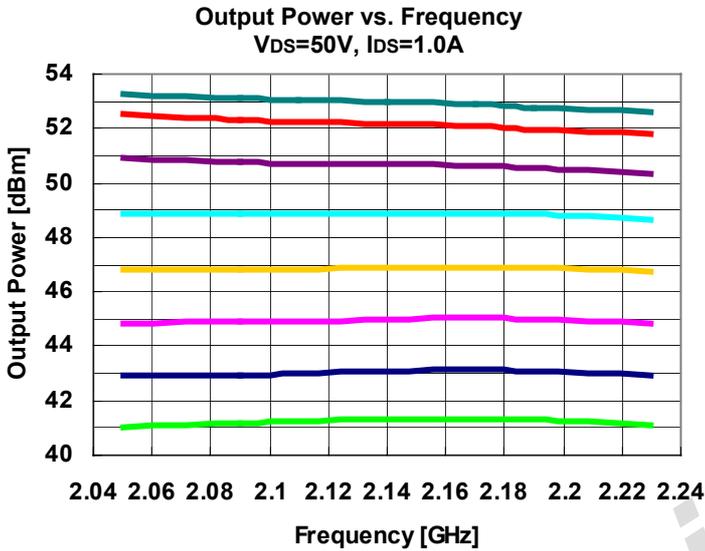
Item	Symbol	Condition	Limit			Unit
			Min.	Typ.	Max.	
Pinch-Off Voltage	V_p	$V_{DS}=50V$ $I_{DS}=72mA$	-1.0	-2.0	-3.5	V
Gate-Drain Breakdown Voltage	V_{GDO}	$I_{GS}=-36 mA$	-	-350	-	V
3rd Order Inter modulation Distortion	IM_3	$V_{DS}=50V$	-	-32	-	dBc
Power Gain	G_p	$I_{DS}(DC)=1.0A$	14.0	15.0	-	dB
Drain Efficiency	η_d	$P_{out}=45dBm(Avg.)$ Note 1	-	32	-	%
Thermal Resistance	R_{th}	Channel to Case	-	0.55	0.7	$^\circ C/W$

Note 1 : IM_3 and Gain test condition as follows:

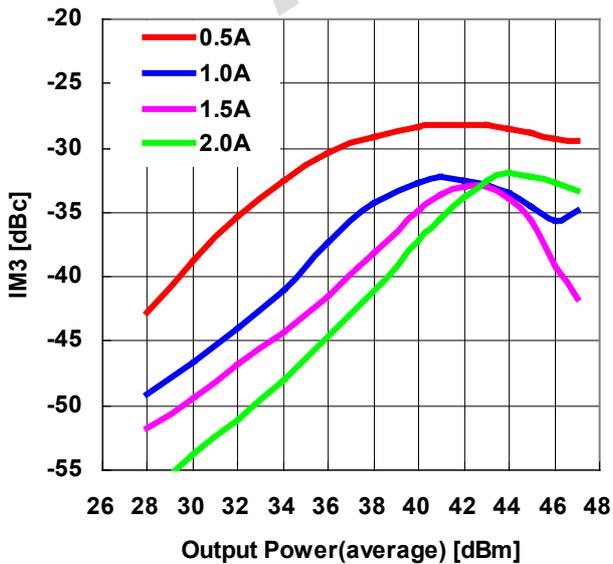
IM_3 & Gain : $f_0=2.135GHz$, $f_1=2.145GHz$ W-CDMA(3GPP3.4 12-00) BS-1 64ch
67% clipping modulation(Peak/Avg. = 8.5dB@0.01% Probability(CCDF)) measured
over 3.84MHz at $f_0-10MHz$ and $f_1+10MHz$.

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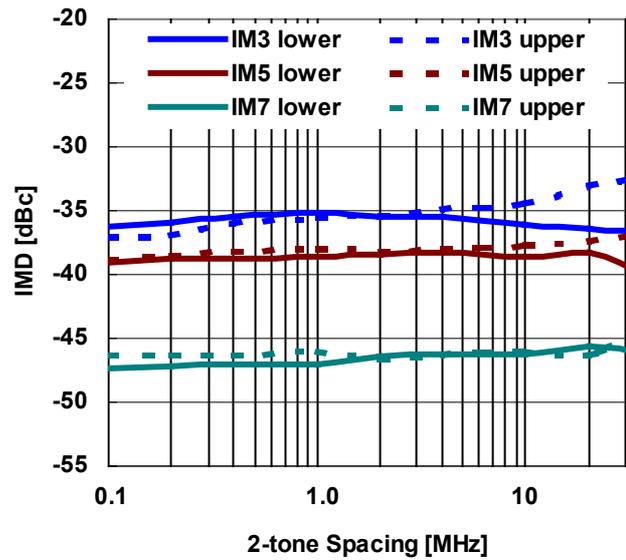
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2-tone IMD vs. Output Power
 $V_{DS}=50V, f_1=2.135GHz, f_2=2.145GHz, 10MHz$ Spacing



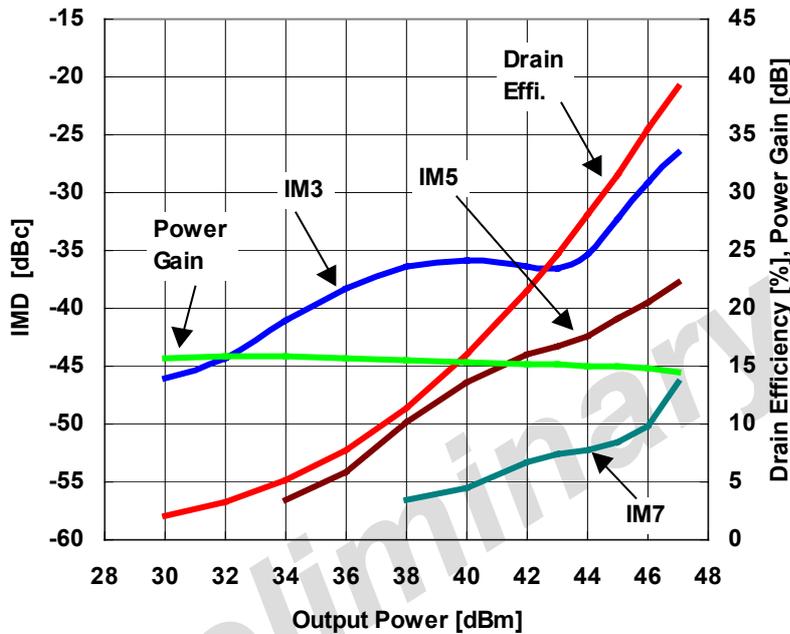
2-tone IMD vs. Tone Spacing, $V_{DS}=50V, I_{DS}=1.0A$
 $P_{out}=45dBm$ (average) Center Frequency=2.14GHz



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2-Carrier IMD, Drain Efficiency and Power Gain vs. Output Power
 $V_{DS}=50V$, $I_{DS}=1.0A$, $f_1=2.135GHz$, $f_2=2.145GHz$ (10MHz Spacing)
 Peak/Avg. = 8.5dB@0.01% Probability(CCDF)



2-Carrier ACLR, Drain Efficiency and Power Gain vs. Output Power with DPD Operation (note $V_{DS}=50V$, $I_{DS}=1.0A$, $f_1=2.1375GHz$, $f_2=2.1425GHz$ (5MHz Spacing) Peak/Avg. = 6.5dB@0.01% Probability(CCDF); Single Carrier Signal Note) Digital Predistortion evaluation test system: PMC-Sierra PALADIN-15 DPD chip-set

